## Application/Control No. Applicant(s)/Patent Under Reexamination 10/600,852 TEH, JIN TEIK Notice of References Cited Examiner Art Unit Page 1 of 1 Chirag R. Patel 2141 U.S. PATENT DOCUMENTS Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0049842 04-2002 Huetsch et al. Α 709/225 В US-C US-US-D US-Ε US-F US-G US-Н US-١ US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS

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